


<b>Search Notes</b>  	<b>Application/Control No.</b>  10589795	<b>Applicant(s)/Patent Under Reexamination</b>  HIGA, TERUO
	<b>Examiner</b>  TAEYOON KIM	<b>Art Unit</b>  1651

SEARCHED			
Class	Subclass	Date	Examiner
435	134; 42; 264 (in combination with claim terms)	2/17/2010	TK
510	507 (in combination with claim terms)	2/17/2010	TK

SEARCH NOTES		
Search Notes	Date	Examiner
134; 42	11/2/2009	TK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
435	134; 42; 264 (in combination with claim terms)	2/17/2010	TK
510	507 (in combination with claim terms) -- see attached search history	2/17/2010	TK

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